	COUNT	DESCRIPTION OF	REVIS	IONS BY CHKD		DATE	E cou		T DE	DESCRIPTION OF REV		VISIONS	BY	CHK	D D	ATE	
<u> </u>							Δ										
		BLE STANDARD	<u> </u>					Δ]			
		Operating Temperature Range		-bb'('to +10b'('(Note1)							etorage -10°C to +60°C (Note3)						
		Operating Humidity Range		20% to 80% (Note 2)						Storag Range	ge Humi	dity	40% to 70% (Note3)				
		Applicable Connector		DF51K-*(D)S-2C (###)						Voltag	oltage 250V AC/DC						
		Applicable Cable								Currer	Current			AWG 30 : 0.5A			
		Insulation Diameter		φ 0.8 mm													
			SPECIFICATIONS TEST METHOD							NS							
\sim		ITEM UCTION			TES	ST ME	THOD					REQUIR	EMENT:	<u> </u>		QT	AT
			Visually and by measuring instrument.														Го
General Examination Marking			Confirmed visually.							Acc	According to drawing.						0
ELE	CTRI	CAL CHARAC	TERISTICS														•
Contact Resistance			20mV MAX, 1mA (DC or 1000Hz).								30 mΩ MAX.						
Milli∨	olt Leve	l Method														0	-
ME	CHAN	ICAL CHARAC	CTERI	STIC	<u>s</u>											ı	1
		Operation	30 times insertion and extraction.								①Contact resistance: 30mΩ MAX						
(Sn Plating)											②No damage, crack or looseness of parts.						_
Mech	nanical (Operation	50 times insertion and extraction.							10	①Contact resistance: 30mΩ MAX						
		(Au Plating)								2N	②No damage, crack or looseness of parts.						
Vibration Shock			Frequency 10 to 55 Hz, single amplitude 0.75 mm,							, ①N	①No electrical discontinuity of 1 μ s.						_
			at 10 cycles for 3 direction.								②No damage, crack or looseness of parts.						
			Acceleration 490 m/s ² duration of pulse 11 ms at 3 times for 3 directions.							3	3						-
			ciiiioo ii	0. 0 0	000,011					+							
ENVIRONMENTAL CHARACTERISTICS												1					
	p Heat		Exposed at 40 ± 2 °C , humidity 90 to 95 %, 96 h.							. ①0	①Contact resistance: 30 mΩ MAX.						
(Steady State)			(After leaving the room temperature for 1 to 2h.)							②N	②No damage, crack or looseness of parts.						-
Rapid Change of			Temperature −55 °C→ +105 °C								①Contact resistance: 30 mΩ MAX.						
Temperature			Time 30min → 30min Under 5 Cycles.								②No damage, crack or looseness of parts.						
			(The transferring time of the tank is 2 to 3 MIN)													0	-
			(After leaving the room temperature for 1 to 2h.)														
Remarks Note 1: Include the temperature rising by current. Note 2: No condensing Note 3: Apply to the condition of long term storage for unused products before pcb on board, after pcb board, operating temperature and humidity range is applied for interim storage during transportation.																	
			D					DRAW	/N	DES	IGNED	CHECKE	ED AF	PROVE	D	RELEA	SED
						J.	J.S CHOI		J.S CHOI		S.M.LI			EN	\rightarrow		
			- IFO 00°	IEC 80512			1	7.12.	22	17.	17.12.22		2.22 17.12.22		20. 02. 13 DEPT		
Unles		rise specified, refer to QUALIFICATION		12. AT: ASSURANCE TEST O: APPLICABLE T					TEST	i	1						
		SE KOREA CO								FT PART NO.							
CODI	E NO.(OL	.D)	DRAWING NO.					CODE	DE NO.			F51K-30SCFA (800)					
CL		,		ELC4-611497						CL 6652-0044-4-800							